

# SN54LS690, SN54LS691, SN54LS693, SN74LS690, SN74LS691, SN74LS693

## SYNCHRONOUS COUNTERS WITH OUTPUT REGISTERS AND MULTIPLEXED 3-STATE OUTPUTS

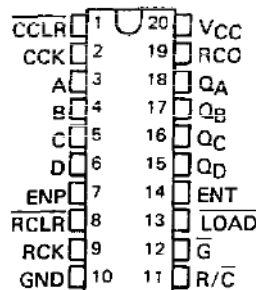
SDLS198

02423, JANUARY 1981—REVISED MARCH 1988

- 4-Bit Counters/Registers
- Multiplexed Outputs for Counter or Latched Data
- 3-State Outputs Drive Bus Lines Directly
- 'LS690 . . . Decade Counter, Direct Clear
- 'LS691 . . . Binary Counter, Direct Clear
- 'LS693 . . . Binary Counter, Synchronous Clear

SN54LS690, SN54LS691, SN54LS693 . . . J PACKAGE  
SN74LS690, SN74LS691, SN74LS693 . . . DW OR N PACKAGE

(TOP VIEW)



### description

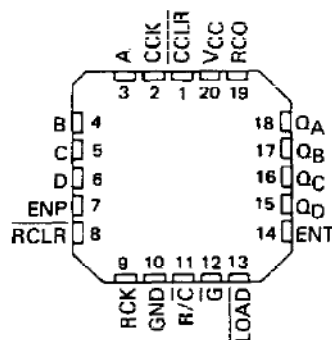
These low-power Schottky LSI devices incorporate synchronous counters, four-bit D-type registers, and quadruple two-line to one-line multiplexers with three-state outputs in a single 20-pin package. The counters can be programmed from the data inputs and have enable P inputs and enable T inputs and a ripple-carry output for easy expansion. The register/counter select input, R/C, selects the counter when low or the register when high for the three-state outputs,  $Q_A$ ,  $Q_B$ ,  $Q_C$ , and  $Q_D$ . These outputs are rated at 12 and 24 milliamperes (54LS/74LS) for good bus-driving performance.

Individual clock and clear inputs are provided for both the counter and the register. Both clock inputs are positive-edge triggered: The clear line is active low and is asynchronous on the 'LS690 and 'LS691, synchronous on the 'LS693. Loading of the counter is accomplished when LOAD is taken low and a positive-transition occurs on the counter clock CCK.

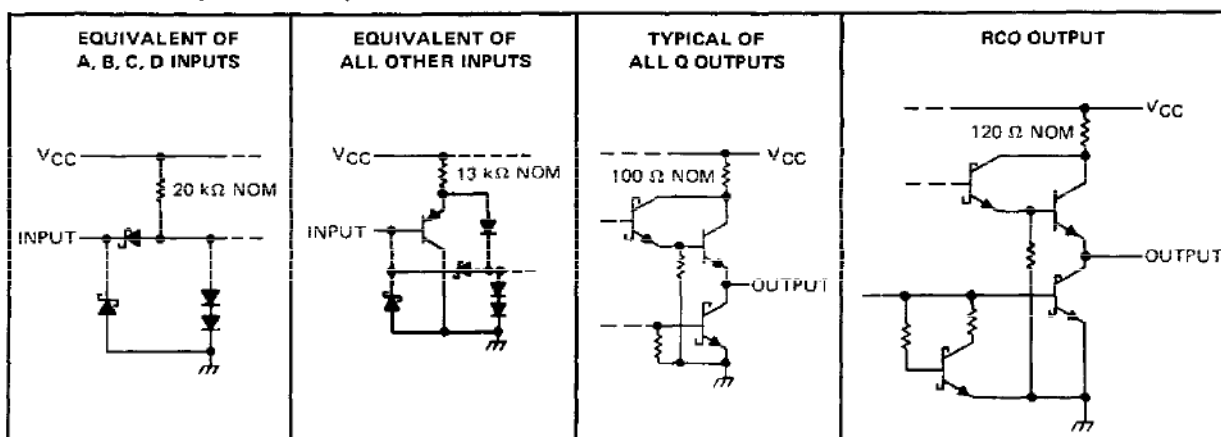
Expansion is easily accomplished by connecting RCO of the first stage to ENT of the second stage, etc. All ENP inputs can be tied common and used as master enable or disable control.

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(TOP VIEW)



### schematics of inputs and outputs



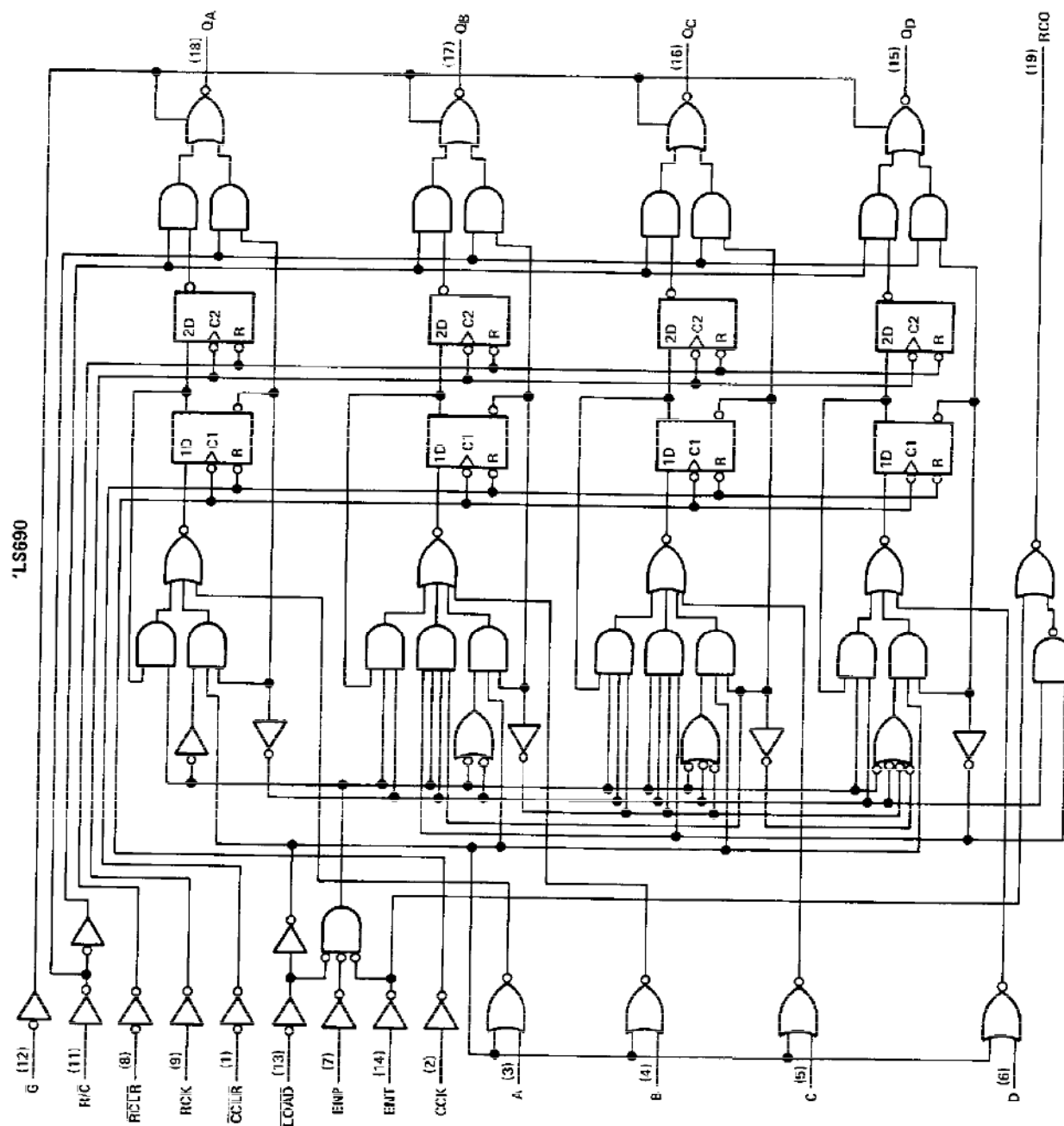
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**SN54LS690, SN74LS690**  
**SYNCHRONOUS COUNTERS WITH OUTPUT REGISTERS**  
**AND MULTIPLEXED 3-STATE OUTPUTS**

logic diagrams (positive logic)

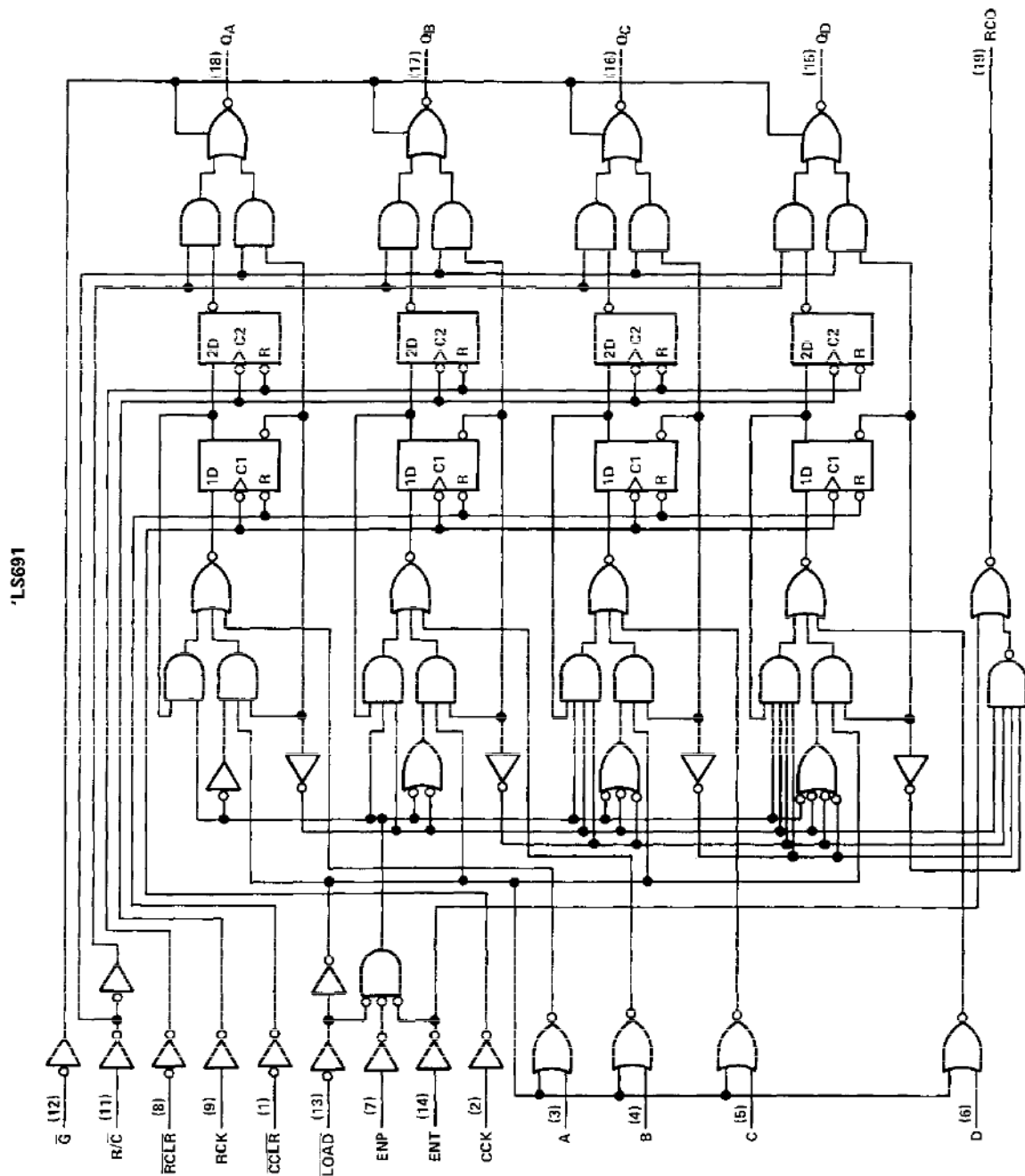


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**SYNCHRONOUS COUNTERS WITH OUTPUT REGISTERS**  
**AND MULTIPLEXED 3-STATE OUTPUTS**

logic diagrams (positive logic) (continued)

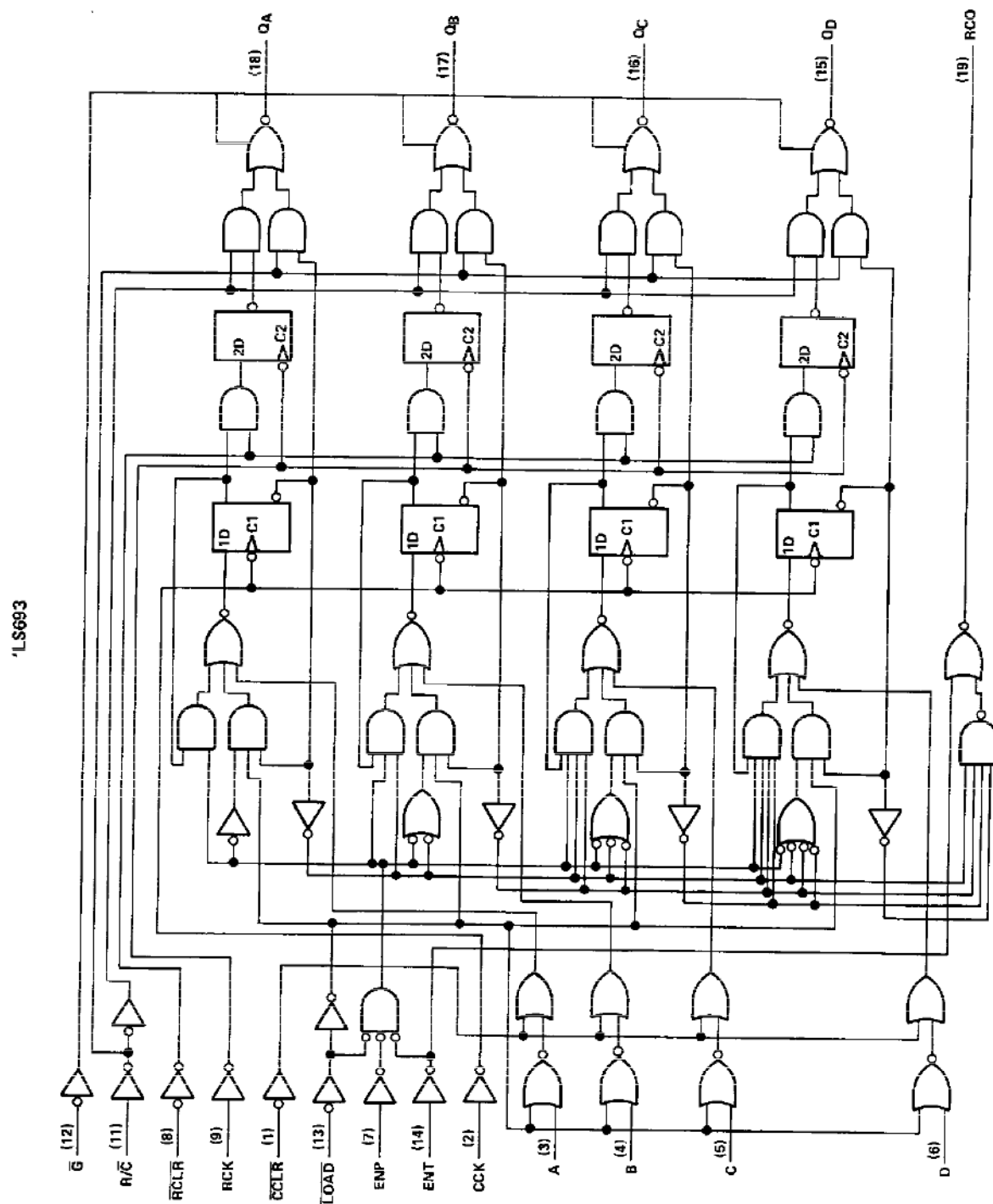


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**SN54LS693, SN74LS693**  
**SYNCHRONOUS COUNTERS WITH OUTPUT REGISTERS**  
**AND MULTIPLEXED 3-STATE OUTPUTS**

logic diagrams (positive logic) (continued)

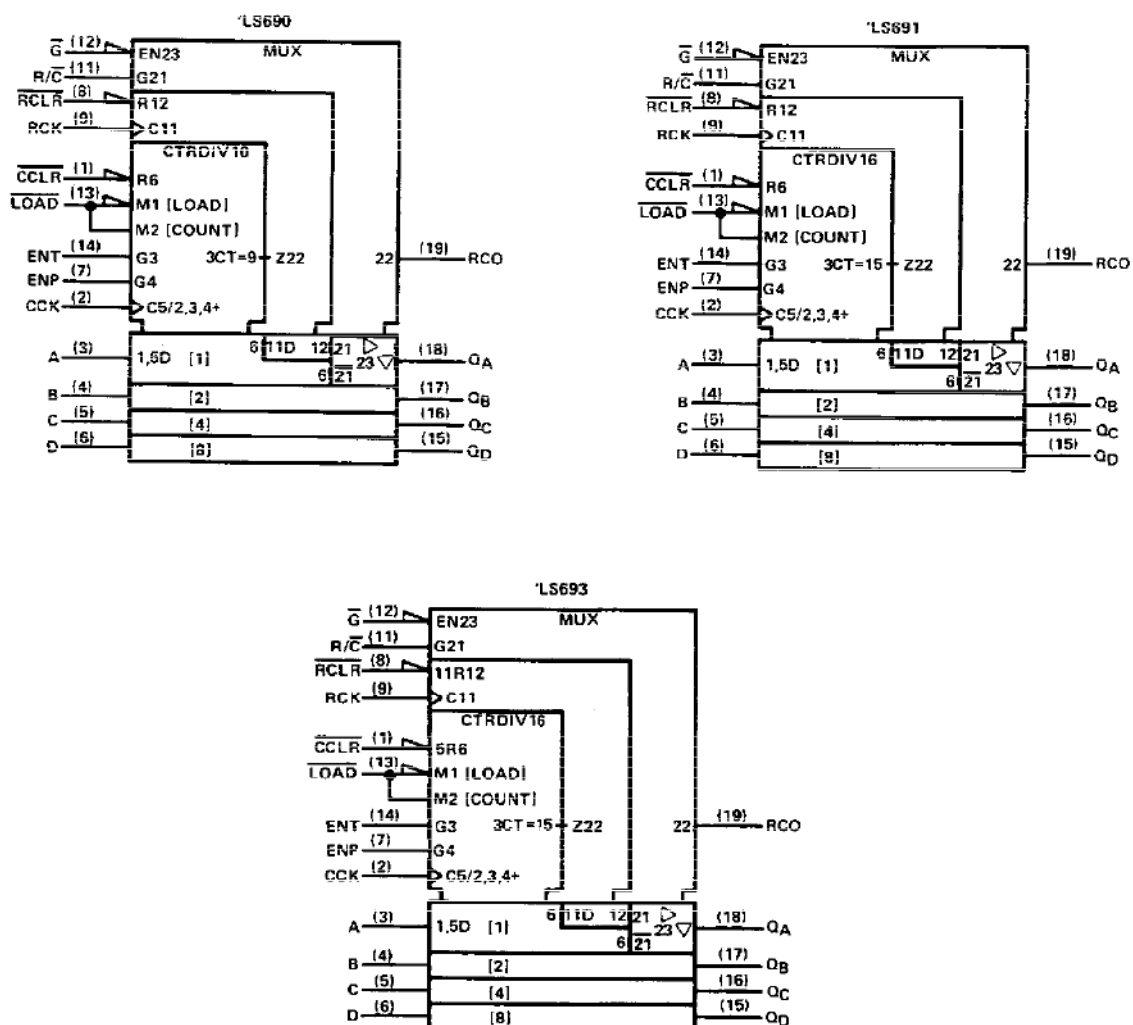


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**SYNCHRONOUS COUNTERS WITH OUTPUT REGISTERS**  
**AND MULTIPLEXED 3-STATE OUTPUTS**

logic symbols†



†These symbols are in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

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**SYNCHRONOUS COUNTERS WITH OUTPUT REGISTERS**  
**AND MULTIPLEXED 3-STATE OUTPUTS**

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, $V_{CC}$ (See Note 1)	7 V
Input voltage	7 V
Off-state output voltage	5.5 V
Operating free-air temperature range: SN54LS690, SN54LS691, SN54LS693	-55°C to 125°C
SN74LS690, SN74LS691, SN74LS693	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		SN54LS'			SN74LS'			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
$V_{CC}$	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
$V_{IH}$	High-level input voltage	2			2			V
$V_{IL}$	Low-level input voltage			0.7			0.8	V
$I_{OH}$	High-level output current	Q		-1			-2.6	mA
		RCO		-0.4			-0.4	mA
$I_{OL}$	Low-level output current	Q		12			24	mA
		RCO		4			8	mA
$f_{clock}$	Clock frequency	CCK		0	20	0	20	MHz
		RCK		0	20	0	20	MHz
$t_w$	Pulse duration	CCK high or low		25	25			ns
		RCK high or low		25	25			
		'LS690, 'LS691		RCLR low	20			
				CCLR low	20			
$t_{su}$	Setup time before CCK ↑			A thru D	30			ns
				ENP or ENT	30			
				LOAD ↓	30			
		'LS693		CCLR ↓	40			
		'LS690, 'LS691		CCLR ↑ inactive	25			
$t_{su}$	Setup time before RCK ↑			CCK ↑ (see Note 2)	30			ns
		'LS690, 'LS691		RCLR ↑ inactive	25			
		'LS693		RCLR ↓	20			
$t_h$	Hold time	Any input from CCK ↑ or RCK ↑		0	0			ns
$T_A$	Operating free-air temperature	-55		125	0		70	°C

NOTE 2: This set up time ensures the register will see stable data from the counter outputs. The clocks may be tied together in which case the register state will be one clock pulse behind the counter.

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**SN54LS690, SN54LS691, SN54LS693, SN74LS690, SN74LS691, SN74LS693**  
**SYNCHRONOUS COUNTERS WITH OUTPUT REGISTERS**  
**AND MULTIPLEXED 3-STATE OUTPUTS**

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†	SN54LS'		SN74LS'		UNIT
			MIN	TYP‡ MAX	MIN	TYP‡ MAX	
V <sub>IK</sub>		V <sub>CC</sub> = MIN, I <sub>I</sub> = -18 mA	-1.5		-1.5		V
V <sub>OH</sub>	Any Q	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = MAX	I <sub>OH</sub> = -1 mA				V
	I <sub>OH</sub> = -2.6 mA		2.4 3.1				
	I <sub>OH</sub> = -0.4 mA		2.5 3.2				
V <sub>OL</sub>	Any Q	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = MAX	I <sub>OL</sub> = 12 mA		0.25 0.4		V
	I <sub>OL</sub> = 24 mA		0.35 0.5				
	I <sub>OL</sub> = 4 mA		0.25 0.4				
	I <sub>OL</sub> = 8 mA		0.35 0.5				
I <sub>OZH</sub>	Any Q	V <sub>CC</sub> = MAX, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = MAX, V <sub>O</sub> = 2.7 V	20		20		μA
I <sub>OZL</sub>	Any Q	V <sub>CC</sub> = MAX, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = MAX, V <sub>O</sub> = 0.4 V	-20		-20		μA
I <sub>I</sub>		V <sub>CC</sub> = MAX, V <sub>I</sub> = 7 V	0.1		0.1		mA
I <sub>IH</sub>		V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.7 V	20		20		μA
I <sub>IL</sub>	A thru D	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.4 V	-0.4		-0.4		mA
	All others		-0.2		-0.2		
I <sub>OS</sub> §	Any Q	V <sub>CC</sub> = MAX, V <sub>O</sub> = 0 V	-30	-130	-30	-130	mA
	RCO		-20	-100	-20	-100	
I <sub>CCH</sub>		V <sub>CC</sub> = MAX, All outputs open	See Note 3		46 65		mA
I <sub>CCL</sub>			See Note 4		48 70		
I <sub>CCZ</sub>			See Note 5		48 70		

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at  $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ .

§ Not more than one output should be shorted at a time and duration of short-circuit should not exceed one second.

NOTES: 3.  $I_{CCH}$  is measured after two 4.5 V to 0-V to 4.5-V pulses have been applied to CCK and RCK while  $\bar{G}$  is grounded and all other inputs are at 4.5 V.

4.  $I_{CCL}$  is measured after two 0-V to 4.5-V to 0-V pulses have been applied to CCK and RCK while all other inputs are grounded.

5.  $I_{CCZ}$  is measured after two 0-V to 4.5-V to 0-V pulses have been applied to CCK and RCK while  $\bar{G}$  is at 4.5 V and all other inputs are grounded.

  
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**SYNCHRONOUS COUNTERS WITH OUTPUT REGISTERS**  
**AND MULTIPLEXED 3-STATE OUTPUTS**

switching characteristics,  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (see note 6)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'LS690, 'LS691		'LS693		UNIT	
				MIN	TYP	MAX	MIN		TYP
$t_{PLH}$	CCK↑	RCO	$R_L = 2\text{ k}\Omega$ , $C_L = 15\text{ pF}$	23	40		23	40	ns
$t_{PHL}$				23	40		23	40	
$t_{PLH}$	ENT	RCO		13	20		13	20	ns
$t_{PHL}$				13	20		13	20	
$t_{PLH}$	CCK↑	Q	$R_L = 667\ \Omega$ , $C_L = 45\text{ pF}$	12	20		12	20	ns
$t_{PHL}$				17	25		17	25	
$t_{PLH}$	RCK↑	Q		12	20		12	20	ns
$t_{PHL}$				17	25		17	25	
$t_{PHL}$	$\overline{\text{CCLR}}\downarrow$	Q		23	40				ns
$t_{PHL}$	$\overline{\text{RCLR}}\downarrow$	Q		20	30				ns
$t_{PLH}$	$R/\overline{\text{C}}$	Q		16	25		16	25	ns
$t_{PHL}$				16	25		16	25	
$t_{PZH}$	$\overline{\text{G}}\downarrow$	Q		19	30		19	30	ns
$t_{PZL}$				19	30		19	30	
$t_{PHZ}$	$\overline{\text{G}}\uparrow$	Q	$R_L = 667\ \Omega$ , $C_L = 5\text{ pF}$	17	30		17	30	ns
$t_{PLZ}$				17	30		17	30	

NOTE 6: Load circuits and voltage waveforms are shown in Section 1.

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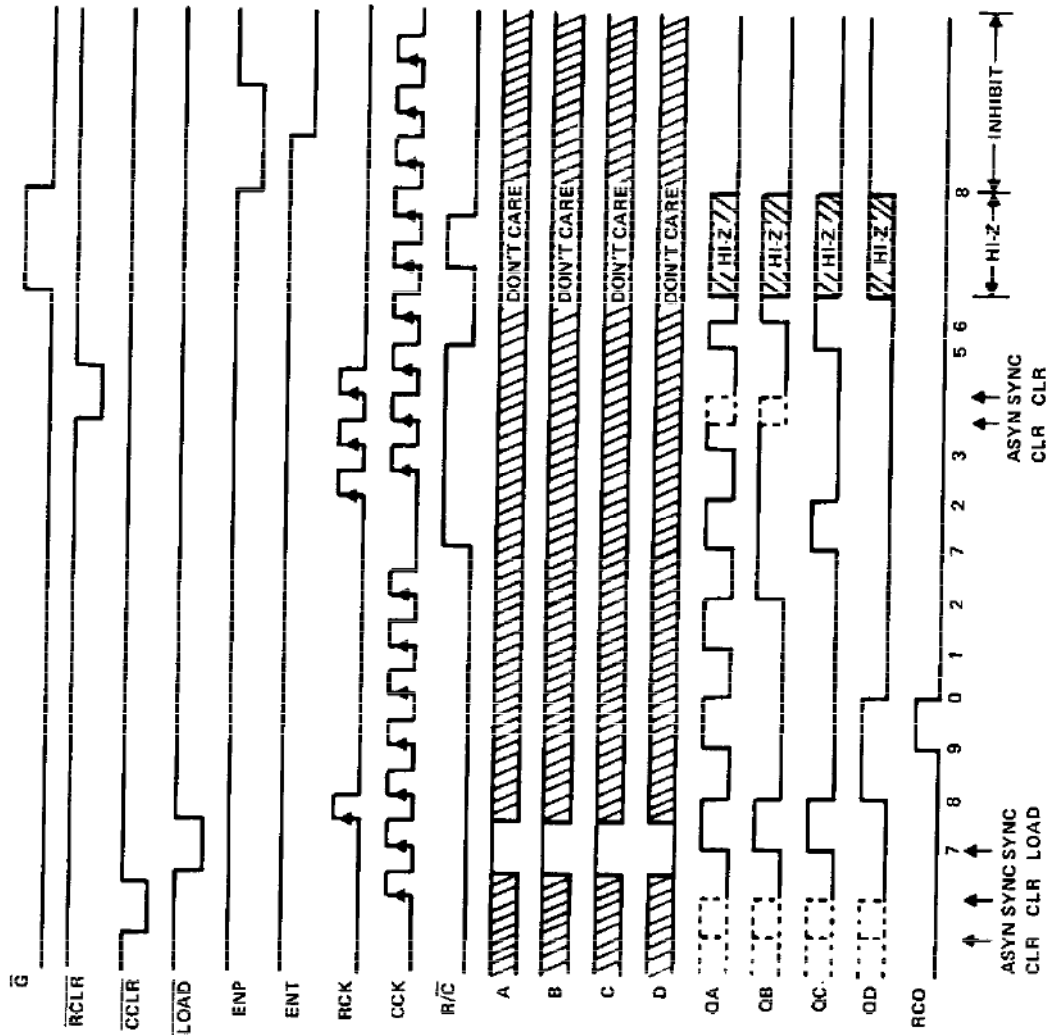
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**SYNCHRONOUS COUNTERS WITH OUTPUT REGISTERS**  
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typical operating sequences

LS690 DECADE COUNTER, Asynchronous Clear

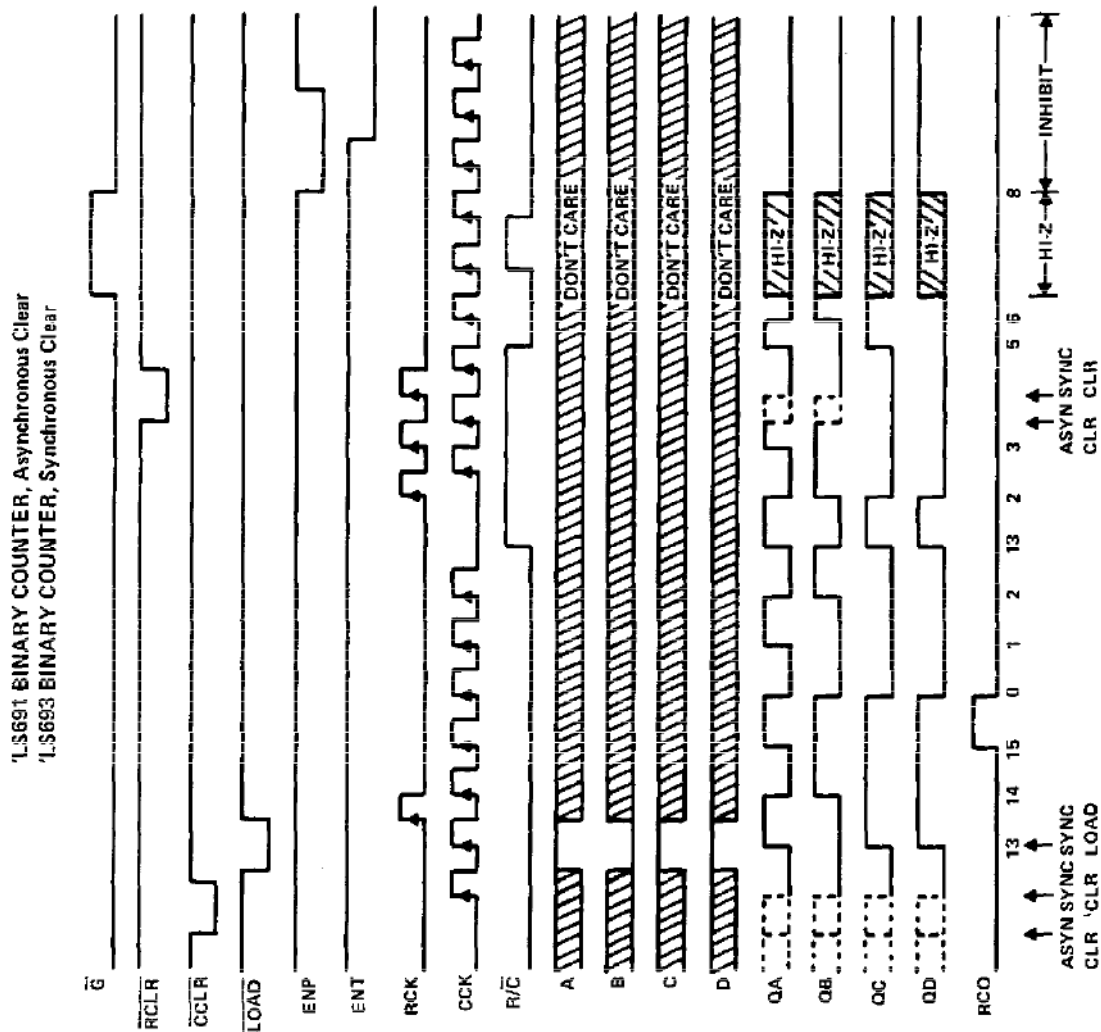


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typical operating sequences (continued)



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